

Notice of References Cited	Application/Control No. 10/058,366	Applicant(s)/Patent Under Reexamination MURAMATSU, TOSHIHIKO	
	Examiner Binh-An D. Nguyen	Art Unit 3713	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0165764 A1	11-2002	WADE et al.	705/14
	B	US-6,764,397 B1	07-2004	Robb, Robert W.	463/23
	C	US-2002/0137217 A1	09-2002	Rowe, Richard E.	436/42
	D	US-2002/0169672 A1	11-2002	Barnhart, Thomas L.	705/14
	E	US-5,913,515 A	06-1999	Takemoto et al.	273/121B
	F	US-5,351,970 A	10-1994	Fioretti, Philip R.	463/19
	G	US-2003/0216968 A1	11-2003	Barnhart, Thomas L.	705/14
	H	US-6,632,139 B1	10-2003	Baerlocher, Anthony J.	463/16
	I	US-2004/0193489	09-2004	Boyd et al.	705/014
	J	US-6,634,946 B1	10-2003	Bridgeman et al.	463/28
	K	US-5,359,510 A	10-1994	Sabaliauskas, Anthony L.	700/91
	L	US-6,007,426 A	12-1999	Kelly et al.	463/16
	M	US-5,816,918 A	10-1998	Kelly et al.	463/16

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP10-151266	09-1998	Japan	Bougaki Tetsuya	
	O	JP2000-245894	12-2000	Japan	Uehata Koshiro	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.